

## IRLM210A-VB Datasheet

### N-Channel 200 V (D-S) MOSFET

#### PRODUCT SUMMARY

|                           |                        |     |
|---------------------------|------------------------|-----|
| $V_{DS}$ (V)              | 200                    |     |
| $R_{DS(on)}$ ( $\Omega$ ) | $V_{GS} = 10\text{ V}$ | 1.2 |
| $Q_g$ (Max.) (nC)         | 8.2                    |     |
| $Q_{gs}$ (nC)             | 1.8                    |     |
| $Q_{gd}$ (nC)             | 4.5                    |     |
| Configuration             | Single                 |     |

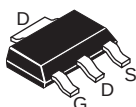
#### FEATURES

- Available in tape and reel
- Dynamic  $dV/dt$  rating
- Repetitive avalanche rated
- Fast switching
- Ease of paralleling
- Simple drive requirements



**RoHS**  
COMPLIANT  
HALOGEN  
**FREE**  
Available

SOT-223



N-Channel MOSFET

#### ABSOLUTE MAXIMUM RATINGS ( $T_C = 25\text{ }^{\circ}\text{C}$ , unless otherwise noted)

| PARAMETER                                                 |                         |                         | SYMBOL                            | LIMIT       | UNIT |
|-----------------------------------------------------------|-------------------------|-------------------------|-----------------------------------|-------------|------|
| Drain-Source Voltage                                      |                         |                         | V <sub>DS</sub>                   | 200         | V    |
| Gate-Source Voltage                                       |                         |                         | V <sub>GS</sub>                   | ± 20        |      |
| Continuous Drain Current                                  | V <sub>GS</sub> at 10 V | T <sub>C</sub> = 25 °C  | I <sub>D</sub>                    | 1.0         | A    |
|                                                           |                         | T <sub>C</sub> = 100 °C |                                   | 0.8         |      |
| Pulsed Drain Current <sup>a</sup>                         |                         |                         | I <sub>DM</sub>                   | 5.0         | W/°C |
| Linear Derating Factor                                    |                         |                         |                                   | 0.025       |      |
| Linear Derating Factor (PCB Mount) <sup>e</sup>           |                         |                         |                                   | 0.017       |      |
| Single Pulse Avalanche Energy <sup>b</sup>                |                         |                         | E <sub>AS</sub>                   | 50          | mJ   |
| Repetitive Avalanche Current <sup>a</sup>                 |                         |                         | I <sub>AR</sub>                   | 0.96        | A    |
| Repetitive Avalanche Energy <sup>a</sup>                  |                         |                         | E <sub>AR</sub>                   | 0.31        | mJ   |
| Maximum Power Dissipation                                 | T <sub>C</sub> = 25 °C  |                         | P <sub>D</sub>                    | 3.1         | W    |
| Maximum Power Dissipation (PCB Mount) <sup>e</sup>        | T <sub>A</sub> = 25 °C  |                         |                                   | 2.0         |      |
| Peak Diode Recovery dV/dt <sup>c</sup>                    |                         |                         | dV/dt                             | 5.0         | V/ns |
| Operating Junction and Storage Temperature Range          |                         |                         | T <sub>J</sub> , T <sub>stg</sub> | -55 to +150 | °C   |
| Soldering Recommendations (Peak Temperature) <sup>d</sup> | for 10 s                |                         |                                   | 300         |      |

#### Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- $V_{DD} = 50\text{ V}$ , starting  $T_J = 25\text{ }^{\circ}\text{C}$ ,  $L = 81\text{ mH}$ ,  $R_G = 25\text{ }\Omega$ ,  $I_{AS} = 0.96\text{ A}$  (see fig. 12).
- $I_{SD} \leq 3.3\text{ A}$ ,  $dI/dt \leq 70\text{ A}/\mu\text{s}$ ,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 150\text{ }^{\circ}\text{C}$ .
- 1.6 mm from case.
- When mounted on 1" square PCB (FR-4 or G-10 material).

**THERMAL RESISTANCE RATINGS**

| PARAMETER                                            | SYMBOL     | MIN. | TYP. | MAX. | UNIT |
|------------------------------------------------------|------------|------|------|------|------|
| Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup> | $R_{thJA}$ | -    | -    | 40   | °C/W |
| Maximum Junction-to-Case (Drain)                     | $R_{thJC}$ | -    | -    | 60   |      |

**Note**

a. When mounted on 1" square PCB (FR-4 or G-10 material).

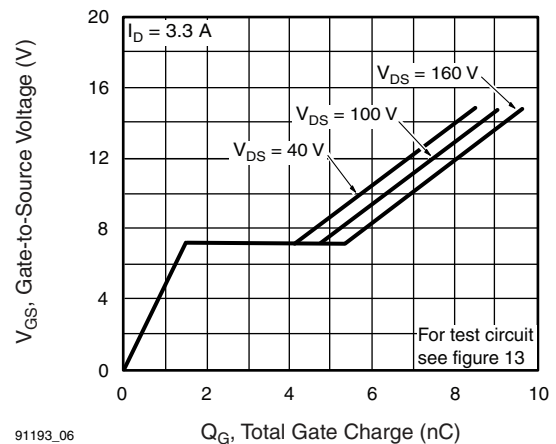
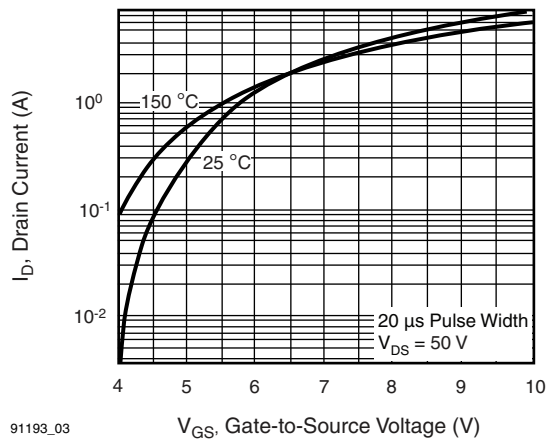
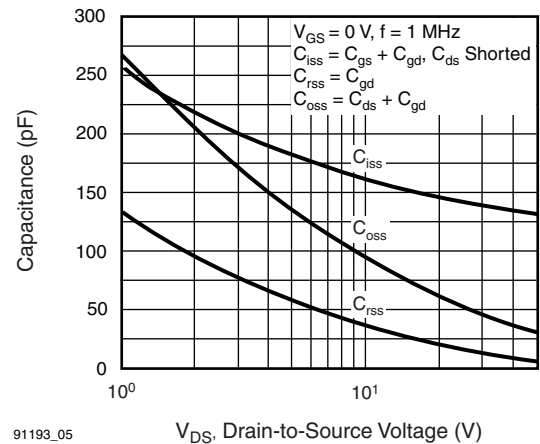
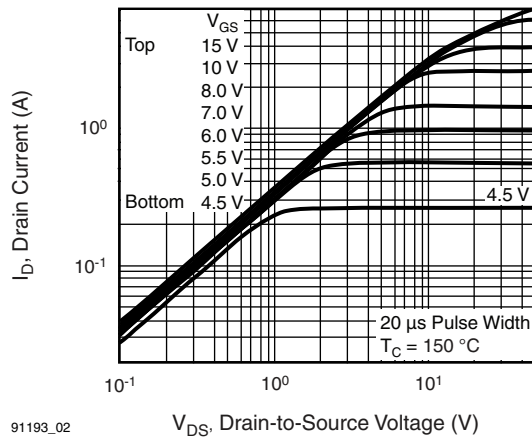
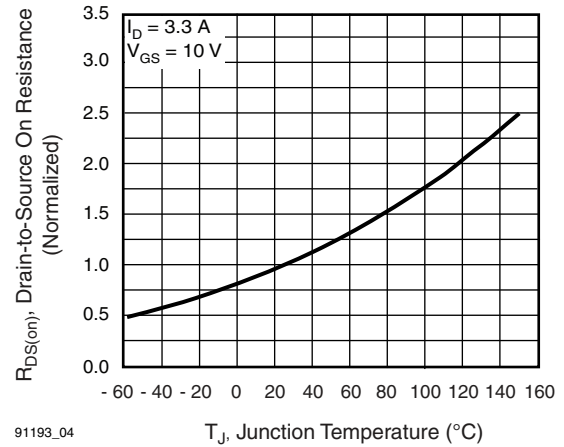
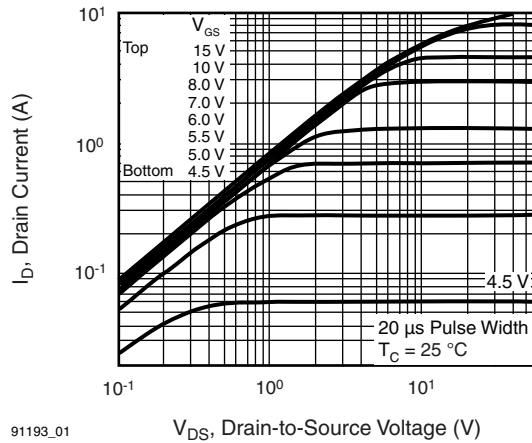
**SPECIFICATIONS** ( $T_J = 25\text{ °C}$ , unless otherwise noted)

| PARAMETER                                 | SYMBOL                           | TEST CONDITIONS                                                                                                            |                                                                                    | MIN. | TYP. | MAX.  | UNIT |
|-------------------------------------------|----------------------------------|----------------------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------|------|------|-------|------|
| Static                                    |                                  |                                                                                                                            |                                                                                    |      |      |       |      |
| Drain-Source Breakdown Voltage            | V <sub>DS</sub>                  | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA                                                                             |                                                                                    | 200  | -    | -     | V    |
| V <sub>DS</sub> Temperature Coefficient   | ΔV <sub>DS</sub> /T <sub>J</sub> | Reference to 25 °C, I <sub>D</sub> = 1 mA                                                                                  |                                                                                    | -    | 0.30 | -     | V/°C |
| Gate-Source Threshold Voltage             | V <sub>GS(th)</sub>              | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA                                                                |                                                                                    | 2.0  | -    | 4.0   | V    |
| Gate-Source Leakage                       | I <sub>GSS</sub>                 | V <sub>GS</sub> = ± 20 V                                                                                                   |                                                                                    | -    | -    | ± 100 | nA   |
| Zero Gate Voltage Drain Current           | I <sub>DSS</sub>                 | V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V                                                                             |                                                                                    | -    | -    | 25    | μA   |
|                                           |                                  | V <sub>DS</sub> = 160 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C                                                    |                                                                                    | -    | -    | 250   |      |
| Drain-Source On-State Resistance          | R <sub>DS(on)</sub>              | V <sub>GS</sub> = 10 V                                                                                                     | I <sub>D</sub> = 0.58 A <sup>b</sup>                                               | -    | 1.2  | -     | Ω    |
| Forward Transconductance                  | g <sub>fs</sub>                  | V <sub>DS</sub> = 50 V, I <sub>D</sub> = 0.58 A                                                                            |                                                                                    | 0.51 | -    | -     | S    |
| Dynamic                                   |                                  |                                                                                                                            |                                                                                    |      |      |       |      |
| Input Capacitance                         | C <sub>iss</sub>                 | V <sub>GS</sub> = 0 V,<br>V <sub>DS</sub> = 25 V,<br>f = 1.0 MHz, see fig. 5                                               |                                                                                    | -    | 140  | -     | pF   |
| Output Capacitance                        | C <sub>oss</sub>                 |                                                                                                                            |                                                                                    | -    | 53   | -     |      |
| Reverse Transfer Capacitance              | C <sub>rss</sub>                 |                                                                                                                            |                                                                                    | -    | 15   | -     |      |
| Total Gate Charge                         | Q <sub>g</sub>                   | V <sub>GS</sub> = 10 V                                                                                                     | I <sub>D</sub> = 3.3 A, V <sub>DS</sub> = 160 V,<br>see fig. 6 and 13 <sup>b</sup> | -    | -    | 8.2   | nC   |
| Gate-Source Charge                        | Q <sub>gs</sub>                  |                                                                                                                            |                                                                                    | -    | -    | 1.8   |      |
| Gate-Drain Charge                         | Q <sub>gd</sub>                  |                                                                                                                            |                                                                                    | -    | -    | 4.5   |      |
| Turn-On Delay Time                        | t <sub>d(on)</sub>               | V <sub>DD</sub> = 100 V, I <sub>D</sub> = 3.3 A,<br>R <sub>g</sub> = 24 Ω, R <sub>D</sub> = 30 Ω, see fig. 10 <sup>b</sup> |                                                                                    | -    | 8.2  | -     | ns   |
| Rise Time                                 | t <sub>r</sub>                   |                                                                                                                            |                                                                                    | -    | 17   | -     |      |
| Turn-Off Delay Time                       | t <sub>d(off)</sub>              |                                                                                                                            |                                                                                    | -    | 14   | -     |      |
| Fall Time                                 | t <sub>f</sub>                   |                                                                                                                            |                                                                                    | -    | 8.9  | -     |      |
| Internal Drain Inductance                 | L <sub>D</sub>                   | Between lead,<br>6 mm (0.25") from<br>package and center of<br>die contact                                                 |                                                                                    | -    | 4.0  | -     | nH   |
| Internal Source Inductance                | L <sub>S</sub>                   |                                                                                                                            |                                                                                    | -    | 6.0  | -     |      |
| Drain-Source Body Diode Characteristics   |                                  |                                                                                                                            |                                                                                    |      |      |       |      |
| Continuous Source-Drain Diode Current     | I <sub>S</sub>                   | MOSFET symbol<br>showing the<br>integral reverse<br>p - n junction diode                                                   |                                                                                    | -    | -    | 0.96  | A    |
| Pulsed Diode Forward Current <sup>a</sup> | I <sub>SM</sub>                  |                                                                                                                            |                                                                                    | -    | -    | 7.7   |      |
| Body Diode Voltage                        | V <sub>SD</sub>                  | T <sub>J</sub> = 25 °C, I <sub>S</sub> = 0.96 A, V <sub>GS</sub> = 0 V <sup>b</sup>                                        |                                                                                    | -    | -    | 2.0   | V    |
| Body Diode Reverse Recovery Time          | t <sub>rr</sub>                  | T <sub>J</sub> = 25 °C, I <sub>F</sub> = 3.3 A, dI/dt = 100 A/μs <sup>b</sup>                                              |                                                                                    | -    | 150  | 310   | ns   |
| Body Diode Reverse Recovery Charge        | Q <sub>rr</sub>                  |                                                                                                                            |                                                                                    | -    | 0.60 | 1.4   | μC   |
| Forward Turn-On Time                      | t <sub>on</sub>                  | Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )                          |                                                                                    |      |      |       |      |

**Notes**

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq 300\text{ }\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)


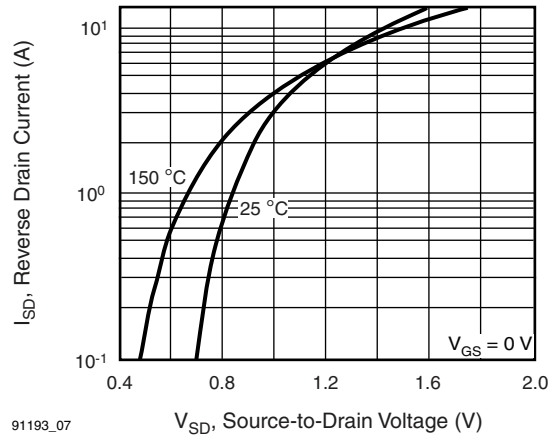


Fig. 7 - Typical Source-Drain Diode Forward Voltage

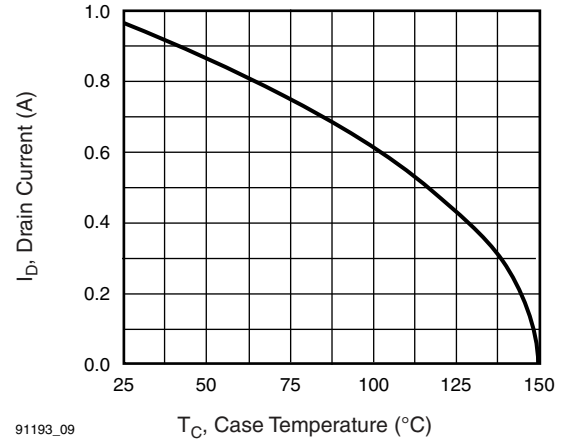


Fig. 9 - Maximum Drain Current vs. Case Temperature

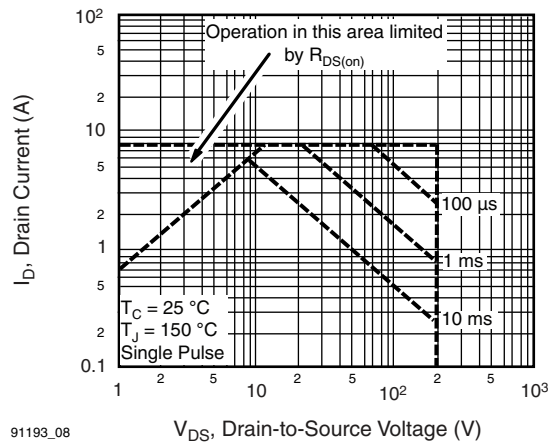


Fig. 8 - Maximum Safe Operating Area

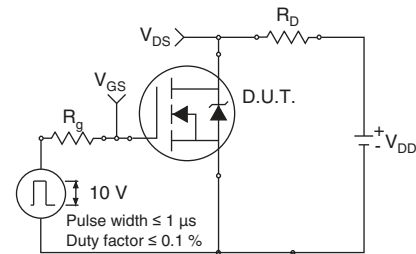


Fig. 10a - Switching Time Test Circuit

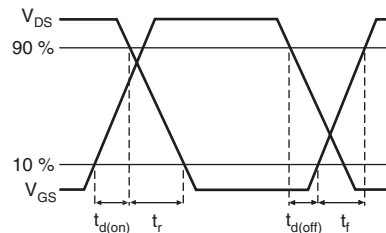


Fig. 10b - Switching Time Waveforms

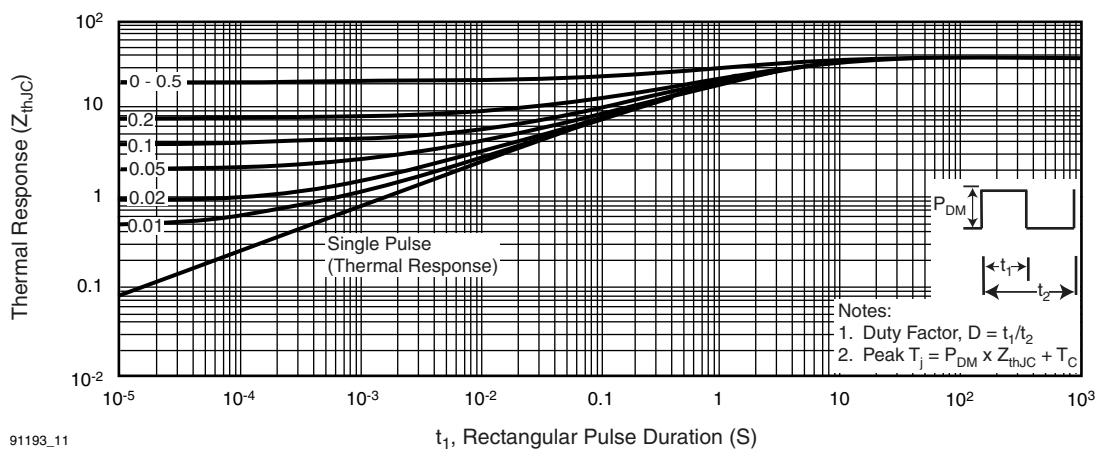


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

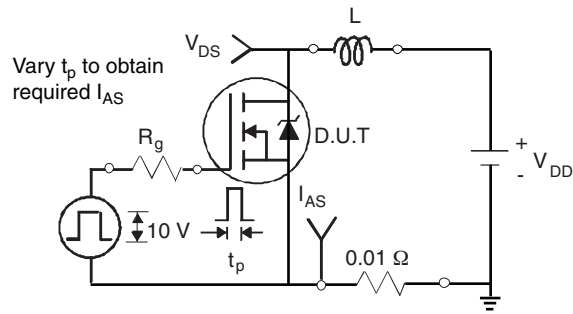


Fig. 12a - Unclamped Inductive Test Circuit

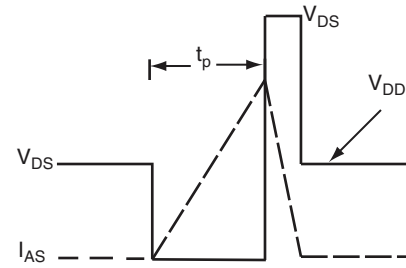


Fig. 12b - Unclamped Inductive Waveforms

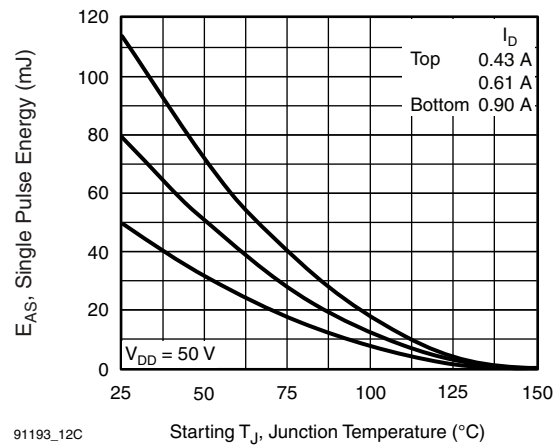


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

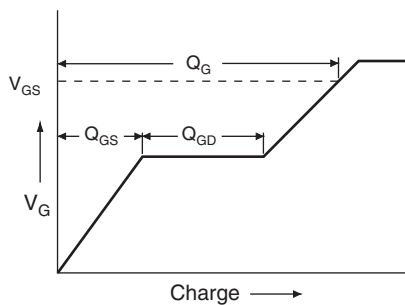


Fig. 13a - Basic Gate Charge Waveform

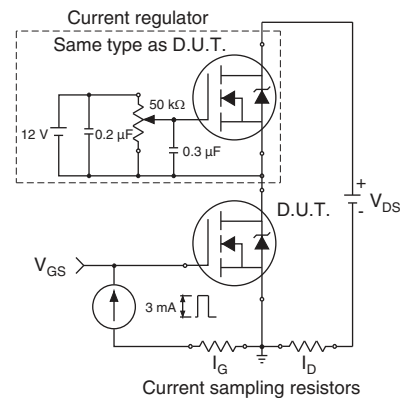
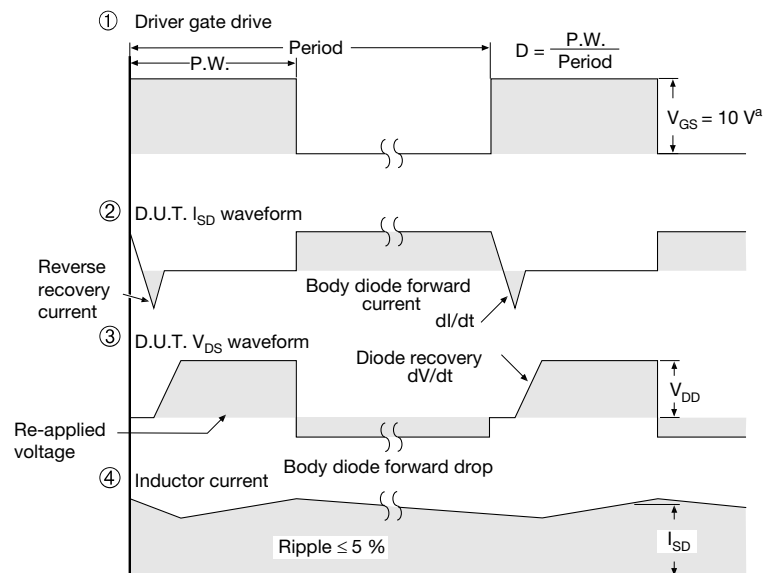
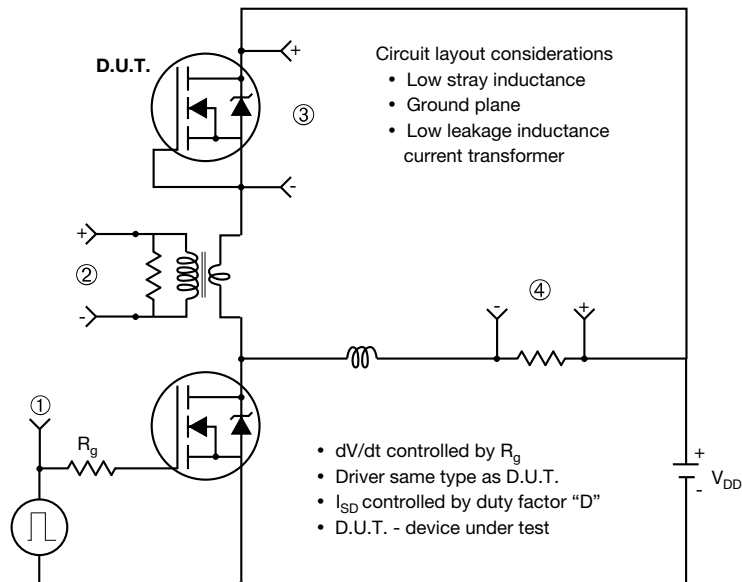


Fig. 13b - Gate Charge Test Circuit

### Peak Diode Recovery $dV/dt$ Test Circuit

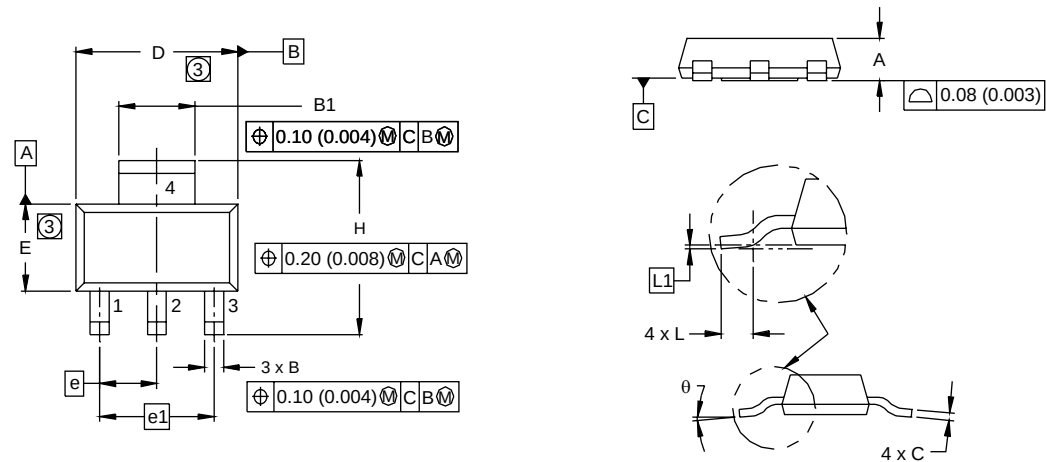


#### Note

a.  $V_{GS} = 5\text{ V}$  for logic level devices

**Fig. 14 - For N-Channel**

**SOT-223**



| DIM.                                        | MILLIMETERS |      | INCHES     |       |
|---------------------------------------------|-------------|------|------------|-------|
|                                             | MIN.        | MAX. | MIN.       | MAX.  |
| A                                           | 1.55        | 1.80 | 0.061      | 0.071 |
| B                                           | 0.65        | 0.85 | 0.026      | 0.033 |
| B1                                          | 2.95        | 3.15 | 0.116      | 0.124 |
| C                                           | 0.25        | 0.35 | 0.010      | 0.014 |
| D                                           | 6.30        | 6.70 | 0.248      | 0.264 |
| E                                           | 3.30        | 3.70 | 0.130      | 0.146 |
| e                                           | 2.30 BSC    |      | 0.0905 BSC |       |
| e1                                          | 4.60 BSC    |      | 0.181 BSC  |       |
| H                                           | 6.71        | 7.29 | 0.264      | 0.287 |
| L                                           | 0.91        | -    | 0.036      | -     |
| L1                                          | 0.061 BSC   |      | 0.0024 BSC |       |
| $\theta$                                    | -           | 10°  | -          | 10°   |
| ECN: S-82109-Rev. A, 15-Sep-08<br>DWG: 5969 |             |      |            |       |

**Notes**

1. Dimensioning and tolerancing per ASME Y14.5M-1994.
2. Dimensions are shown in millimeters (inches).
3. Dimension do not include mold flash.
4. Outline conforms to JEDEC outline TO-261AA.

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